

<b>Notice of References Cited</b>	Application/Control No. 10/531,184	Applicant(s)/Patent Under Reexamination SHER, ARIEH	
	Examiner Joel M. Lamprecht	Art Unit 3737	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,728,319 A	03-1988	Masch, Helmut	604/22
*	B	US-5,047,040 A	09-1991	Simpson et al.	606/159
*	C	US-5,100,424 A	03-1992	Jang et al.	606/159
*	D	US-5,318,576 A	06-1994	Plassche et al.	606/159
*	E	US-5,429,136 A	07-1995	Milo et al.	600/439
*	F	US-5,569,276 A	10-1996	Jang et al.	606/159
*	G	US-5,993,469 A	11-1999	McKenzie et al.	606/159
*	H	US-5,997,557 A	12-1999	Barbut et al.	606/159
*	I	US-6,120,516 A	09-2000	Selmon et al.	606/159
*	J	US-6,398,798 B1	06-2002	Selmon et al.	606/159
*	K	US-6,852,097 B1	02-2005	Fulton, III, Richard E.	604/266
*	L	US-2005/0113853 A1	05-2005	Noriega et al.	606/159
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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